

March 12, 2003

## NEWS AND ANNOUNCEMENTS

### Teradyne Expands Presence in China

As high-technology companies continue to increase operations in Asia, and particularly in China, Teradyne is keeping pace by expanding its sales, support and manufacturing facilities there. March 11, 2003 marked the official opening ceremony of the company's new Shanghai facility, which provides a broad range of test services for semiconductor devices, test and inspection systems for printed circuit boards, and high-density connectors, backplanes and complex system integration and test services. Click here to read more about this event:

<http://www.teradyne.com/>

### NetVendor Acquires Teradyne's Manufacturing Software Group and Creates New Company

NetVendor and Teradyne announced that the two companies have completed the sales of Teradyne's Manufacturing Software Group (MSG) to NetVendor, Inc. The two groups, both located in the metro Atlanta area, have merged to become Visiprise, Inc. To read more about the new corporation and its focus, click here:

<http://www.teradyne.com/prods/sce>

### Circuit Board Test and Inspection - About Us (Facts & Figures)

A new feature has been added to our web site to provide you with an overview of Teradyne, Inc., and the Assembly Test Division (ATD). This section includes general business information and describes our markets, products, and office locations. Check out the **About Us - Facts and Figures** tab on the ATD home page or click here:

[http://www.teradyne.com/prods/cbt/aboutus/abt\\_factfigure.html](http://www.teradyne.com/prods/cbt/aboutus/abt_factfigure.html)

## UPCOMING EVENTS

### Dixie Crow Symposium XXVIII: "Transforming EW: New Solutions for a New World" - Warner Robins Air Force Base, Georgia - March 23-27, 2003

The Electronic Warfare (EW) Management Directorate, Warner Robins Air Logistics Center, and the Dixie Crow Chapter of the Association of Old Crows sponsor this annual event. The symposium features government and industry exhibits of technological interest, and the program includes technical sessions and courses related to electronic warfare. Visit Teradyne at Booth #7 where we will be exhibiting the Bi4-Series™ Multiple Module Serial Bus Test Instrument and the Ai7-Series™ Analog Test Instrument Subsystem. Click here for more information about this event:

<http://www.teradyne.com/prods/cbt/news/tradeshows/03dixiecrow.html>

### APEX 2003 Pre-Show Web Seminar - \*\*\* Preview Presentation

Teradyne has prepared a 20-minute Pre-Show Web Seminar focused on our participation at APEX 2003. For a preview of the new and innovative solutions that Teradyne will feature at APEX 2003 and for more information about our participation in the technical conference program, click here to access the pre-recorded presentation (to watch the APEX preview, you will need the Webex Player; instructions are provided to download the player):

<http://www.teradyne.com/prods/cbt/cbthome.html>

### **APEX 2003 – Anaheim, CA – March 31-April 2, 2003**

Teradyne will be launching two new products -- the Optima 7210™ Optical Process Test (OPT) System and the TestStation LH™. In addition, the integrated test and inspection strategy area of our booth will feature the Optima™ 7300 Post-Reflow Automated Optical Inspection system, the XStation HS™ 4010 In-Line High-Speed Automated X-ray Inspection system, the TestStation SE™ In-Circuit Test system, and Design-to-Build (D2B) Strategist™ software. Visit Teradyne at Booth #2050 to see what's new at Teradyne. Click here for complete details about the APEX event:

<http://www.teradyne.com/prods/cbt/news/tradeshows/03apex.html>

### **NEPCON SHANGHAI 2003 – Shanghai, China – April 8-11, 2003**

Visit Teradyne's Assembly Test Division and Test Connection Systems Division at Booth #2F01, Level 2, where we will be featuring the new TestStation LH™ In-Circuit test system. Click here for more information about this event:

<http://www.teradyne.com/prods/cbt/news/tradeshows/03nepconshanghai.html>

### **Teradyne Users' Group (TUG), Nashville, TN – May 5-7, 2003**

It's time to register to attend TUG. Information about conference registration for speakers, customers, and Teradyne employees is available on the TUG website. Make your plans now. Register early. To access complete information about conference registration and fees, click here:

<http://www.teradyne.com/prods/tug/t2003register.html>

## **PRODUCT INFORMATION**

### **Announcing the Optima™ 7300-Series Version D.0 Software Release \*\*\* Available for Shipment April 1, 2003**

Version D.0 is a new, major software upgrade for the Optima 7300-Series, Post-Reflow Automated Optical Inspection (AOI) system platform, which offers significant new capabilities including "Optical Character Verification" (OCV) and "Optical Character Recognition" (OCR). To read more about the features of the software release and how to obtain the software upgrade, click here:

[http://www.teradyne.com/prods/cbt/products/aoi/7300/7300\\_swd0.html](http://www.teradyne.com/prods/cbt/products/aoi/7300/7300_swd0.html)

### **GR Navigate Version 5.7.0 Software Update \*\*\* Available for Shipment April 1, 2003**

GR Navigate 5.7.0 is the latest version of Teradyne's software for GR228X and TestStation hardware test platforms. It replaces previous versions of GR228X and GR Navigate software and provides a powerful, yet easy-to-use environment for developing and debugging board test programs. Click here to learn more about the features of the update and its availability:

[http://www.teradyne.com/prods/cbt/products/ict/teststation/teststation\\_sw.html](http://www.teradyne.com/prods/cbt/products/ict/teststation/teststation_sw.html)

## Major Documentation Updates to the Customer Zone

As a result of a Teradyne Quality Improvement Team, a new process was created to publish documentation to the Customer Zone (password-protected area). Now you can go to the Customer Zone and view the latest versions of online documentation for the Ai7-Series™ Analog Test Instrument, L-Series™ CShell, LASAR™ Test Simulation Software, M9-Series™ Digital Test Instrument, Spectrum™ 9100-Series Functional Test Platform, TestStudio™ ATE Operating Environment, TPS Converter Studio™, and VICTORY™ Boundary Scan Software. Click here to download documentation:

[http://www.teradyne.com/prods/cbt/support/sup\\_home.html](http://www.teradyne.com/prods/cbt/support/sup_home.html)

You must have an account to download files from the Customer Zone web site. Click here to request an account:

[http://www.teradyne.com/prods/cbt/support/sup\\_f\\_logreq.html](http://www.teradyne.com/prods/cbt/support/sup_f_logreq.html)

## RECENT TECHNICAL PAPERS, ARTICLES, & PUBLICATIONS

### "Digital Defences" – Teradyne Global Case Study

Marconi Selenia Communications is a leading supplier in the defense communications sector worldwide, meeting the needs of Defense Ministries, NATO Agencies, Ministries of Home Affairs and other government agencies. The company designs, manufactures, and supplies communications and information systems, primarily for defense and security applications including ground, naval, avionic communications/command and control systems. Click here to read about the integration of Teradyne's powerful and flexible M910 Digital Test Instrument (DTI) into the Marconi Selenia Communications general-purpose automatic test equipment (GPATE) platform:

<http://www.teradyne.com/prods/cbt/products/library/m9s/marconiselenia.pdf>

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<http://www.teradyne.com/prods/cbt/cbthome.html>

Both *eTeraView* and *Teradyne Perspective* are available on the Teradyne web page for your reference. Access *Newsletters* at:

[http://www.teradyne.com/prods/cbt/news/news\\_pubs.html](http://www.teradyne.com/prods/cbt/news/news_pubs.html)

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